PATENT COOPERATION TREATY

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INTERNATIONAL PRELIMINARY REPORT ON PATENTABILITY

(Chapter I of the Patent Cooperation Treaty)

(PCT Rule 44bis)

Applicant's or agent's file reference PHUS030357WO	FOR FURTHER ACTION	See item 4 below			
International application No. PCT/IB2004/052145	International filing date (day/month/year) 19 October 2004 (19.10.2004)	Priority date (day/month/year) 20 October 2003 (20.10.2003)			
International Patent Classification (8th edition unless older edition indicated) See relevant information in Form PCT/ISA/237					
Applicant KONINKLIJKE PHILIPS ELECTRO	NICS, N.V.				

1.		mational preliminary report on patentability (Chapter I) is issued by the International Bureau on behalf of the onal Searching Authority under Rule 44 bis. 1(a).					
2.	This REPORT consists of a total of 9 sheets, including this cover sheet.						
	In the attached sheets, any reference to the written opinion of the International Searching Authority should be read as a reference to the international preliminary report on patentability (Chapter I) instead.						
3.	This report contains indications	relating to the following items:					
	Box No. I	Basis of the report					
	Вох №. П	Priority					
	Box No. III	Non-establishment of opinion with regard to novelty, inventive step and industrial applicability					
	Box No. IV	Lack of unity of invention					
	Box No. V	Reasoned statement under Article 35(2) with regard to novelty, inventive step or industrial applicability; citations and explanations supporting such statement					
	Box No. VI	Certain documents cited					
	Box No. VII	Certain defects in the international application					
	Box No. VIII	Certain observations on the international application					
4.		ommunicate this report to designated Offices in accordance with Rules 44bis.3(c) and 93bis.1 but makes an express request under Article 23(2), before the expiration of 30 months from the priority					
		Date of issuance of this report 24 April 2006 (24.04.2006)					

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Form PCT/IB/373 (January 2004)

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From the 'INTERNATIONAL SEARCHING AUTHORITY

PCT To: WRITTEN OPINION OF THE see form PCT/ISA/220 INTERNATIONAL SEARCHING AUTHORITY (PCT Rule 43bis.1) Date of mailing (day/month/year) see form PCT/ISA/210 (second sheet) FOR FURTHER ACTION Applicant's or agent's file reference See paragraph 2 below see form PCT/ISA/220 International filing date (day/month/year) Priority date (day/month/year) International application No. 20.10.2003 19.10.2004 PCT/IB2004/052145 International Patent Classification (IPC) or both national classification and IPC G03F7/20 **Applicant** KONINKLIJKE PHILIPS ELECTRONICS, N.V. 0 This opinion contains indications relating to the following items: Basis of the opinion ☑ Box No. I ☐ Box No. II **Priority** Non-establishment of opinion with regard to novelty, inventive step and industrial applicability Box No. III Lack of unity of invention Box No. IV Reasoned statement under Rule 43bis.1(a)(i) with regard to novelty, inventive step or industrial Box No. V applicability; citations and explanations supporting such statement Certain documents cited ☐ Box No. VI Certain defects in the international application Box No. VII Box No. VIII Certain observations on the international application **FURTHER ACTION** 2. If a demand for international preliminary examination is made, this opinion will usually be considered to be a written opinion of the International Preliminary Examining Authority ("IPEA"). However, this does not apply where the applicant chooses an Authority other than this one to be the IPEA and the chosen IPEA has notifed the International Bureau under Rule 66.1 bis(b) that written opinions of this International Searching Authority will not be so considered. If this opinion is, as provided above, considered to be a written opinion of the IPEA, the applicant is invited to submit to the IPEA a written reply together, where appropriate, with amendments, before the expiration of three months from the date of mailing of Form PCT/ISA/220 or before the expiration of 22 months from the priority date, whichever expires later. For further options, see Form PCT/ISA/220. For further details, see notes to Form PCT/ISA/220. 3.

PATENT COOPERATION TREATY

Name and mailing address of the ISA:

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Authorized Officer

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Form (PCT/ISA/237) (Cover Sheet) (January 2004)

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WRITTEN OPINION OF THE INTERNATIONAL SEARCHING AUTHORITY

International application No. PCT/IB2004/052145

	Box No. I	Basis of the opinion
1.	With regard	d to the language , this opinion has been established on the basis of the international application in ge in which it was filed, unless otherwise indicated under this item.
	langua	pinion has been established on the basis of a translation from the original language into the following age , which is the language of a translation furnished for the purposes of international search? Rules 12.3 and 23.1(b)).
2.	With regard necessary	d to any nucleotide and/or amino acid sequence disclosed in the international application and to the claimed invention, this opinion has been established on the basis of:
	a. type of I	material:
	□ as	sequence listing
•	□ tab	ole(s) related to the sequence listing
	b. format o	of material:
	□ in	written format
	□ in	computer readable form
	c. time of	filing/furnishing:
		entained in the international application as filed.
	☐ file	ed together with the international application in computer readable form.
	☐ fu	rnished subsequently to this Authority for the purposes of search.
3	has b	dition, in the case that more than one version or copy of a sequence listing and/or table relating thereto been filed or furnished, the required statements that the information in the subsequent or additional es is identical to that in the application as filed or does not go beyond the application as filed, as opriate, were furnished.

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WRITTEN OPINION OF THE INTERNATIONAL SEARCHING AUTHORITY

International application No. PCT/IB2004/052145

	No. III Non-establishment of licability	fopli	nion with regard to novelty, inventive step and industrial
The obv	questions whether the claimed i ious), or to be industrially applica	nven able h	tion appears to be novel, to involve an inventive step (to be non nave not been examined in respect of:
	the entire international application	on,	
\boxtimes	claims Nos. 15		
bec	ause:		
	the said international application does not require an international	n, or al pre	the said claims Nos. relate to the following subject matter which liminary examination (specify):
	the description, claims or drawing unclear that no meaningful opin	ngs <i>(</i> lion c	indicate particular elements below) or said claims Nos. are so could be formed (specify):
	the claims, or said claims Nos. could be formed.	are s	o inadequately supported by the description that no meaningful opinion
図	no international search report h	as be	een established for the whole application or for said claims Nos. 15
	the nucleotide and/or amino aci	id sed ions i	quence listing does not comply with the standard provided for in Annex in that:
	the written form		has not been furnished
			does not comply with the standard
	the computer readable form		has not been furnished
			does not comply with the standard
	the tables related to the nucleon not comply with the technical re	otide a equir	and/or amino acid sequence listing, if in computer readable form only, do ements provided for in Annex C-bis of the Administrative Instructions.
	See separate sheet for further	detai	ils ·

WRITTEN OPINION OF THE INTERNATIONAL SEARCHING AUTHORITY

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International application No. PCT/IB2004/052145

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Вс	x No. IV	Lack of unity of	nvention				
\boxtimes	In resp	onse to the invitatior	(Form PC	CT/ISA/206	o pay additional fees, the applicant has:		
		paid additional fees	-				
		paid additional fees	under pro	test.			
	×	not paid additional	fees.				
	This Au	uthority found that tholicant to pay additio	e requiren nal fees.	nent of unit	of invention is not complied with and chose	not to invite	
Tr	nis Author	rity considers that th	e requirem	ent of unit	of invention in accordance with Rule 13.1, 13	3.2 and 13.3	
	complie	d with					
\boxtimes	not com	plied with for the fol	lowing reas	sons:	•		
	see se	eparate sheet					
C			een estab	lished in re	pect of the following parts of the internationa	l application	
\boxtimes	the part	parts relating to claims Nos. 1-14					
	, and passes						
B	ox No. V idustrial	Reasoned state applicability; citati	ment undo	er Rule 43 xplanatio	is.1(a)(i) with regard to novelty, inventive supporting such statement	step or	
. s	tatement						
Ν	ovelty (N)	Yes: No:	Claims Claims	1-14		
Ir	iventive s	step (IS)	Yes: No:	Claims Claims	1-14		
lr	ndustrial a	applicability (IA)	Yes: No:	Claims Claims	1-14		
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see separate sheet

RE SECTION IV

Claims 1-14 are directed to methods for determining the relative swing curve amplitudes for a plurality of wafer processes in which reflectances as a function of wavelength of different photoresist coated wafers are compared.

Claim 15 is directed to a plurality of wafers coated by different processes which have been exposed to actinic radiation.

In view of the prior art at hand US4308586 (Fig. 3) which discloses a plurality of substrates wafers coated with photoresist layers of different thickness (different processes) and whose reflectances are measured versus wavelength, the feature of claims 1-14 which could possibly represent an inventive contribution to the prior art is:

a) determining the relative swing amplitude for a plurality of processes from reflectance versus wavelength curve maxima and minima measurements.

Since this is however not a feature comprised in subject-matter directed to a plurality of wafers (claim 15) on which this step is performed, since this step does not have any affect on the wafers, there is no common inventive concept linking these sets of claims.

BE SECTION V

1. The present application relates to a method for determining the relative swing curve amplitudes for a plurality of wafer processes in which reflectance as a function of wavelength of different photo resist coated wafers are compared.

The following documents are referred to:

D1=US4308586;

D2=EP0727715.

The "swing curve" is the variation of a critical dimension such as line width as a

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function of resist thickness - since the resist is not perfectly uniform across the substrate the same dose of radiation at the actinic wavelength will cause line width variations. The claimed methods are directed to comparing the relative merits of different processes for coating wafers with photo resist with regard to minimising the swing the curve (best critical dimension "CD" control) and to achieve this without requiring either the thickness variation of the resists across the sample surface or the developed line widths to be measured.

The object of the claimed invention is said to be achieved by effectively deducing the variation of critical dimension with respect to resist thickness variation from the measured variation of reflectance (at maximal and minimal excursions) with respect to wavelength in the vicinity of the actinic wavelength for various photo resist coating processes.

2. CLARITY AND INTERPRETATION OF CLAIMS

- "for providing different a top antireflective coating" appears to be a typographical error (different implies a plurality of coatings) and broad enough that the antireflective coating is not necessarily present but rather only marginally limiting to the extent that the second photo resist is suitable for having such an AR coating provided thereon.
- although claim 1 is directed to determining relative swing curve amplitudes there is no step comprised in the method which is directed to determining such amplitudes. In this respect it is noted that determining a value "related to" CD (critical dimensions) encompasses a value of any parameter of the optical system (e.g. thickness, refractive index of layers, substrate).
- "first and second processes". This wording is sufficiently broad to encompass the processes being the same.
- "peak height, valley data" is broad enough to encompass e.g. the wavelengths corresponding to curve locations at maxima and minima and not necessarily the value of reflectance at these locations.

3. PRIOR ART

D1 (Fig. 3) discloses a plurality of substrates wafers coated with photo resist layers of different thickness (different processes) and whose reflectance are measured versus wavelength.

D2 (Figs. 3A-B) discloses three arrangements 15a, 20a and 30a of photo resist on a silicon substrate which produce respectively three reflectance spectra 15, 20 and 30 (Fig. 3B) which were obtained using the Nanometrics 4000 Series spectral reflectometer using ultraviolet light (UV) consisting of a plurality of wavelengths from about 200 to 800 nm (including actinic wavelength).

4. NOVELTY

Claims 1-14 meet the requirement of novelty (Art. 33.2 PCT) vis a vis the prior art in view of the feature:

a) determining the relative swing ratio for a plurality of processes from reflectance versus wavelength curve maxima and minima measurements.

Note:

With respect to claim 1, the final step of "determining a value relating to CD" should be amended to "determining relative swing curve amplitudes" for consistency with the title of the method in claim 1, lines 1-2.

5. INVENTIVE STEP

Re a):

Although several documents of the prior art, in particular D1, D2 do disclose measurement of the sinusoidal characteristic of reflectance versus wavelength for a plurality of wafers coated by different photo resist processes, none of them discloses or suggests that the peak and valley data of these characteristic can be used to deduce

WRITTEN OPINION OF THE INTERNATIONAL SEARCHING AUTHORITY (SEPARATE SHEET)

International application No.

PCT/IB2004/052145

relative swing curve amplitudes.

Claims 1-14 therefore meet the requirement of inventive step (Art. 33.3 PCT).